Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/038,169	BONEH ET AL.	
Examiner	Art Unit	
Baotran N. To	2135	

SEARCHED					
Class	Subclass	Date	Examiner		
713	165, 171, 189	11/8/2007	вт		
726	2	11/8/2007	ВТ		
705	51	11/8/2007	ВТ		
709	223	11/8/2007	вт		

INTERFERENCE SEARCHED					
Class	Subclass ["]	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
EAST SEARCH (USPAT; USPGPUB; EPO; JPO; DERWENT; IBM_TDB)	11/8/2007	ВТ
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